



## 60V 2.4mΩ N-Ch Power MOSFET

## Features

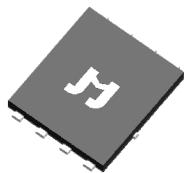
- Ultra-low ON-resistance,  $R_{DS(ON)}$
- Low Gate Charge,  $Q_g$
- 100% UIS and  $R_g$  Tested
- Pb-free Lead Plating
- Halogen-free and RoHS-compliant
- AEC-Q101 Qualified for Automotive Applications

## Product Summary

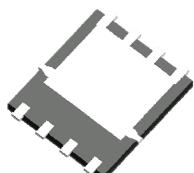
Parameter	Value	Unit
$V_{DS}$	60	V
$V_{GS(th)}_{Typ}$	1.6	V
$I_D (@ V_{GS} = 10V)$ <sup>(1)</sup>	147	A
$R_{DS(ON)}_{Typ} (@ V_{GS} = 10V)$	2.4	mΩ
$R_{DS(ON)}_{Typ} (@ V_{GS} = 4.5V)$	3.4	mΩ

PDFN5x6-8L

Top View

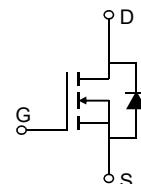
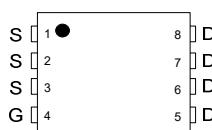


Bottom View



Pin Configuration

Top View

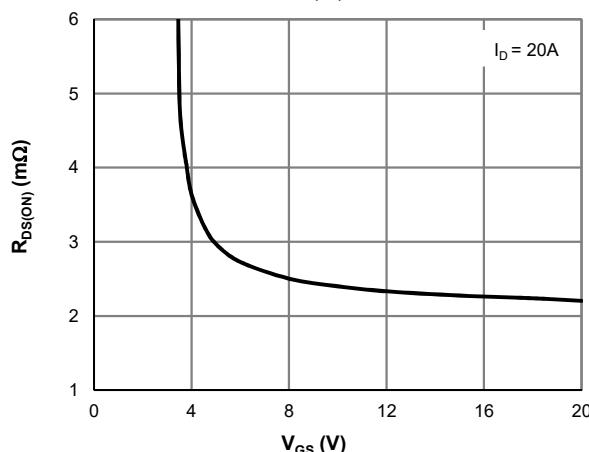


## Ordering Information

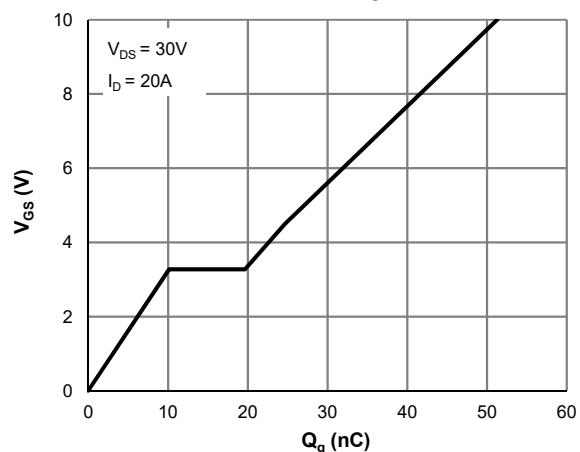
Device	Package	# of Pins	Marking	MSL	$T_J$ (°C)	Media	Quantity (pcs)
JMSL0603BGQ-13	PDFN5x6-8L	8	SL0603BQ	1	-55 to 175	13-inch Reel	3000

Absolute Maximum Ratings (@  $T_A = 25^\circ\text{C}$  unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-to-Source Voltage	$V_{DS}$	60	V
Gate-to-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current (1)	$I_D$	147	A
$T_C = 100^\circ\text{C}$		104	
Pulsed Drain Current (2)	$I_{DM}$	588	A
Avalanche Energy (3)	$E_{AS}$	338	mJ
Power Dissipation (4)	$P_D$	136	W
$T_C = 100^\circ\text{C}$		68	
Junction & Storage Temperature Range	$T_J, T_{STG}$	-55 to 175	°C

 $R_{DS(ON)}$  vs.  $V_{GS}$ 

Gate Charge



**Electrical Characteristics (@  $T_J = 25^\circ\text{C}$  unless otherwise specified)**

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
<b>STATIC PARAMETERS</b>						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$	60			V
Zero Gate Voltage Drain Current	$I_{\text{DSS}}$	$V_{DS} = 48\text{V}, V_{GS} = 0\text{V}$ $T_J = 55^\circ\text{C}$			1.0 5.0	$\mu\text{A}$
Gate-Body Leakage Current	$I_{GSS}$	$V_{DS} = 0\text{V}, V_{GS} = \pm 20\text{V}$			$\pm 100$	nA
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	1.2	1.6	2.5	V
Static Drain-Source ON-Resistance	$R_{DS(\text{ON})}$	$V_{GS} = 10\text{V}, I_D = 20\text{A}$		2.4	3.0	$\text{m}\Omega$
		$V_{GS} = 4.5\text{V}, I_D = 15\text{A}$		3.4	4.4	$\text{m}\Omega$
Forward Transconductance	$g_{FS}$	$V_{DS} = 5\text{V}, I_D = 20\text{A}$		77		S
Diode Forward Voltage	$V_{SD}$	$I_S = 1\text{A}, V_{GS} = 0\text{V}$		0.65	1.0	V
Diode Continuous Current	$I_S$	$T_C = 25^\circ\text{C}$			136	A
<b>DYNAMIC PARAMETERS<sup>(5)</sup></b>						
Input Capacitance	$C_{iss}$	$V_{GS} = 0\text{V}, V_{DS} = 30\text{V}, f = 1\text{MHz}$		3174		pF
Output Capacitance	$C_{oss}$			872		pF
Reverse Transfer Capacitance	$C_{rss}$			39		pF
Gate Resistance	$R_g$	$V_{GS} = 0\text{V}, V_{DS} = 0\text{V}, f = 1\text{MHz}$		1.5		$\Omega$
<b>SWITCHING PARAMETERS<sup>(5)</sup></b>						
Total Gate Charge (@ $V_{GS} = 10\text{V}$ )	$Q_g$	$V_{GS} = 0 \text{ to } 10\text{V}$ $V_{DS} = 30\text{V}, I_D = 20\text{A}$		51		nC
Total Gate Charge (@ $V_{GS} = 4.5\text{V}$ )	$Q_g$			25		nC
Gate Source Charge	$Q_{gs}$			10.1		nC
Gate Drain Charge	$Q_{gd}$			9.5		nC
Turn-On DelayTime	$t_{D(\text{on})}$	$V_{GS} = 10\text{V}, V_{DS} = 30\text{V}$ $R_L = 1.5\Omega, R_{\text{GEN}} = 6\Omega$		15.9		ns
Turn-On Rise Time	$t_r$			67		ns
Turn-Off DelayTime	$t_{D(\text{off})}$			64		ns
Turn-Off Fall Time	$t_f$			108		ns
Body Diode Reverse Recovery Time	$t_{rr}$	$I_F = 20\text{A}, dI_F/dt = 100\text{A}/\mu\text{s}$		49		ns
Body Diode Reverse Recovery Charge	$Q_{rr}$	$I_F = 20\text{A}, dI_F/dt = 100\text{A}/\mu\text{s}$		52		nC

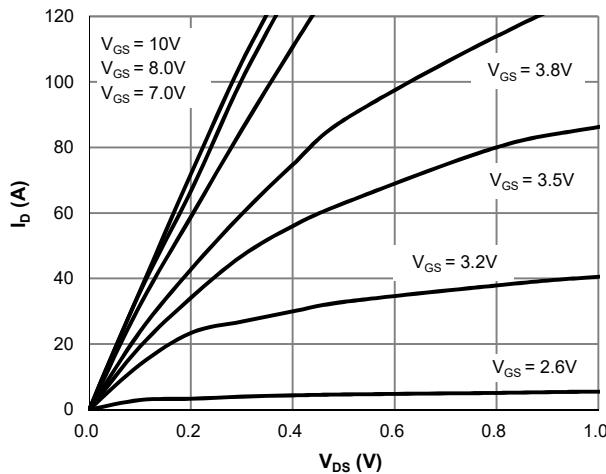
**Thermal Performance**

Parameter	Symbol	Typ.	Max.	Unit
Thermal Resistance, Junction-to-Ambient	$R_{\theta,\text{JA}}$	45	55	$^\circ\text{C/W}$
Thermal Resistance, Junction-to-Case	$R_{\theta,\text{JC}}$	1.1	1.3	$^\circ\text{C/W}$

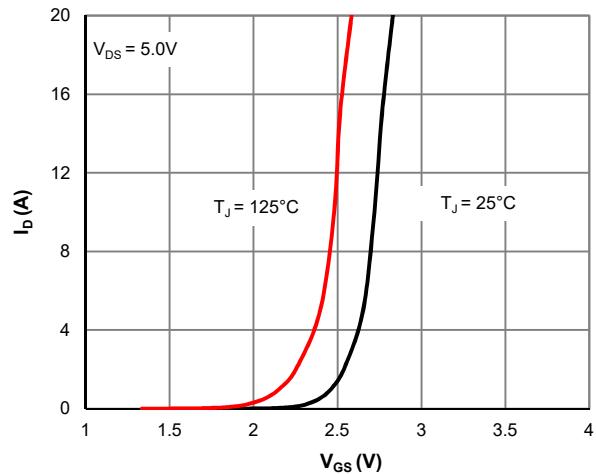
**Notes:**

1. Computed continuous current assumes the condition of  $T_{J,\text{Max}}$  while the actual continuous current depends on the thermal & electro-mechanical application board design.
2. This single-pulse measurement was taken under  $T_{J,\text{Max}} = 175^\circ\text{C}$ .
3.  $E_{AS}$  of 338 mJ is based on starting  $T_J = 25^\circ\text{C}, L = 3.0\text{mH}, I_{AS} = 15\text{A}, V_{GS} = 10\text{V}, V_{DD} = 30\text{V}; 100\%$  test at  $L = 0.3\text{mH}, I_{AS} = 40\text{A}$ .
4. The power dissipation  $P_D$  is based on  $T_{J,\text{Max}} = 175^\circ\text{C}$ .
5. This value is guaranteed by design hence it is not included in the production test.

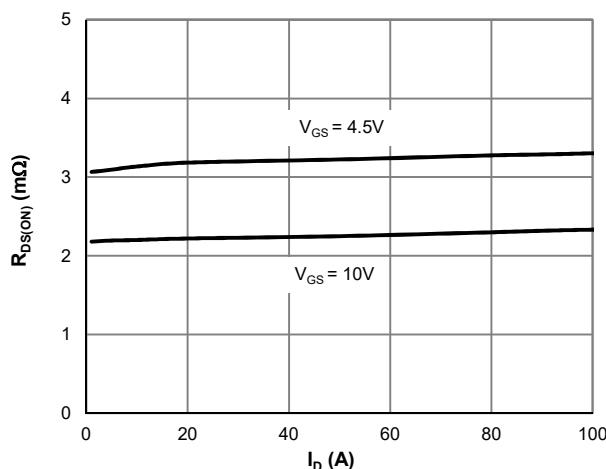
### Typical Electrical & Thermal Characteristics



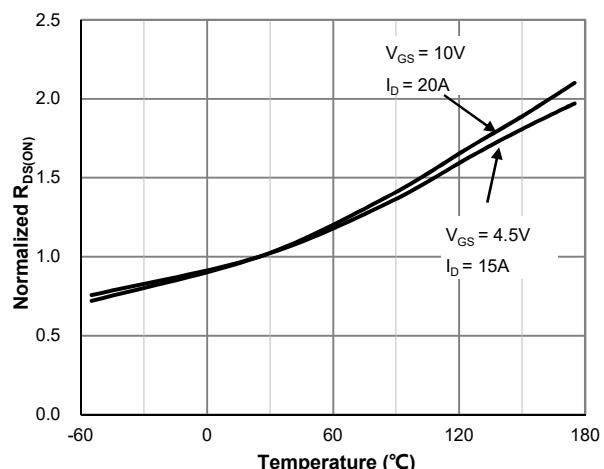
**Figure 1: Saturation Characteristics**



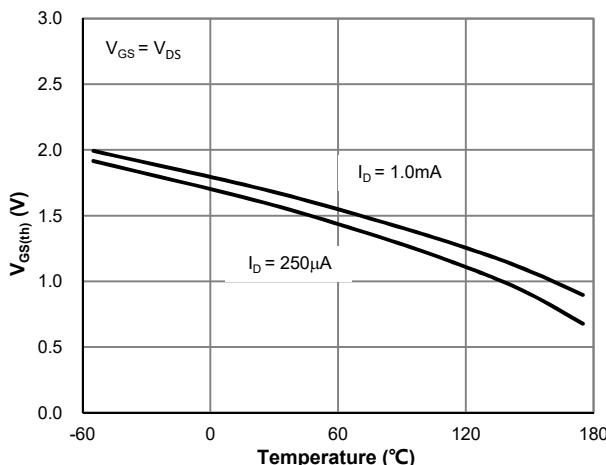
**Figure 2: Transfer Characteristics**



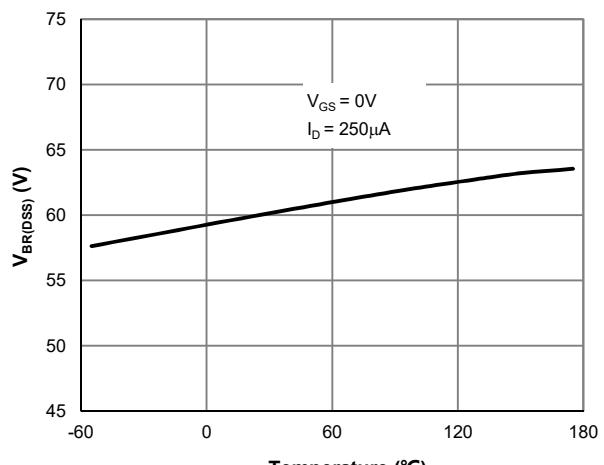
**Figure 3:  $R_{DS(\text{ON})}$  vs. Drain Current**



**Figure 4:  $R_{DS(\text{ON})}$  vs. Junction Temperature**

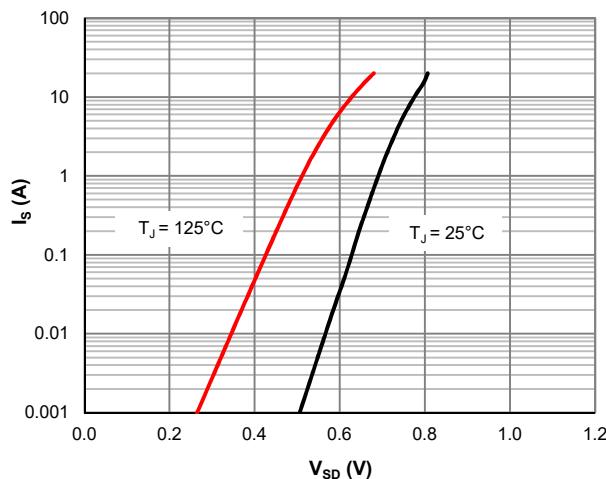


**Figure 5:  $V_{GS(\text{th})}$  vs. Junction Temperature**

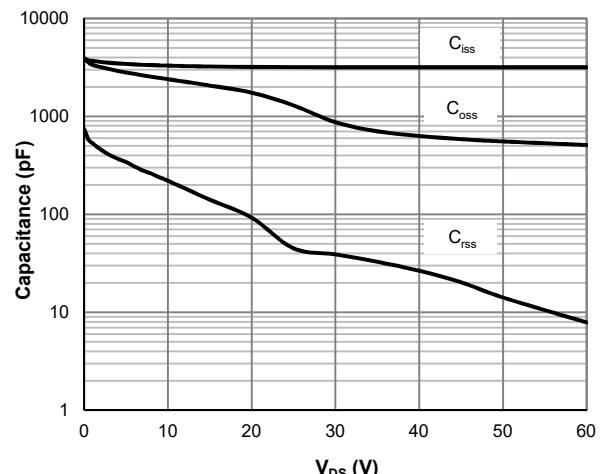


**Figure 6:  $V_{BR(\text{DSS})}$  vs. Junction Temperature**

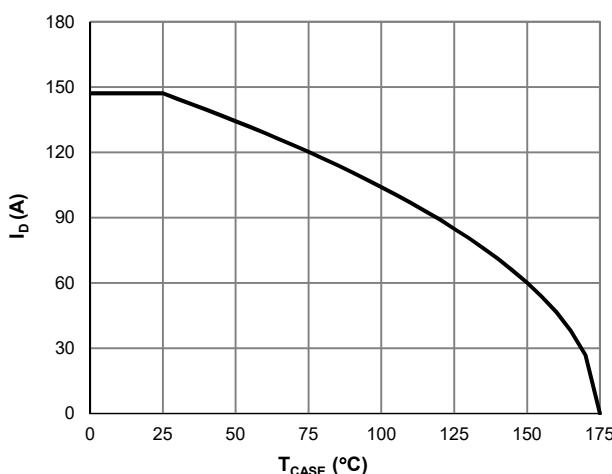
### Typical Electrical & Thermal Characteristics



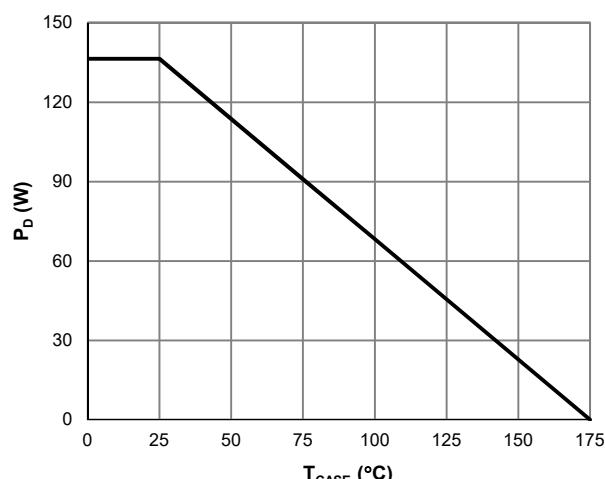
**Figure 7: Body-Diode Characteristics**



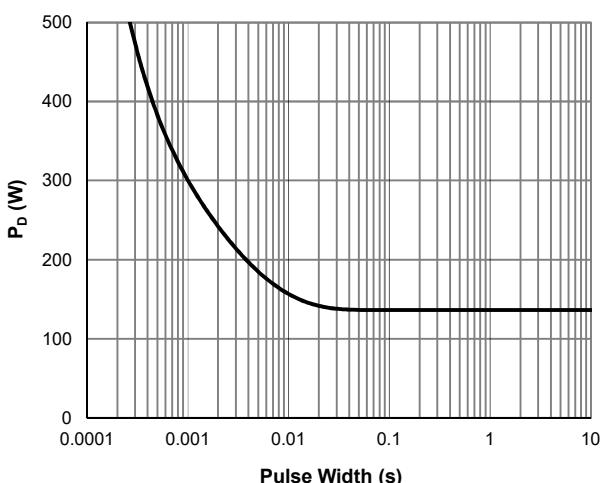
**Figure 8: Capacitance Characteristics**



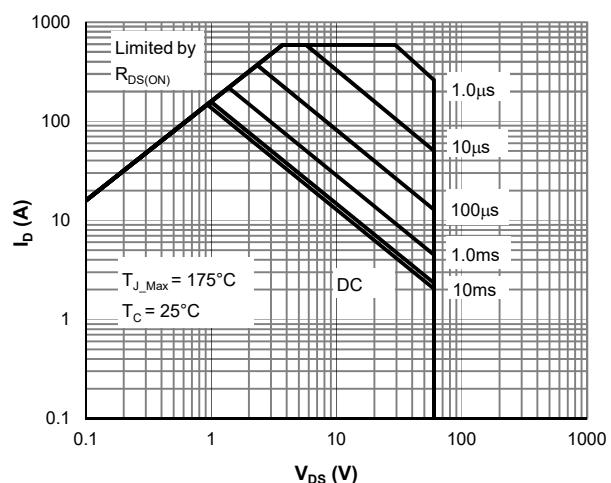
**Figure 9: Current De-rating**



**Figure 10: Power De-rating**



**Figure 11: Single Pulse Power Rating, Junction-to-Case**



**Figure 12: Maximum Safe Operating Area**

### Typical Electrical & Thermal Characteristics

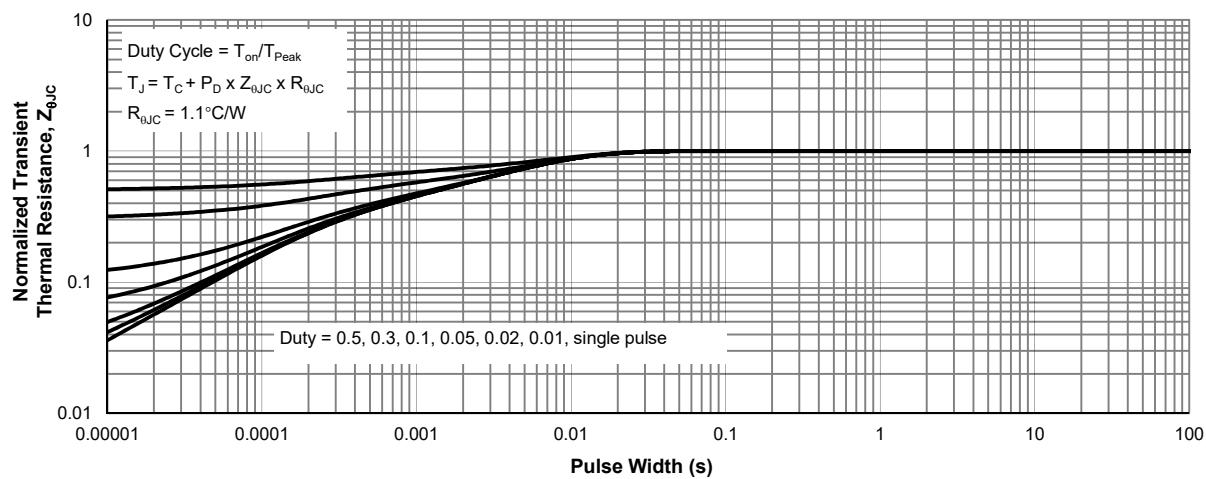
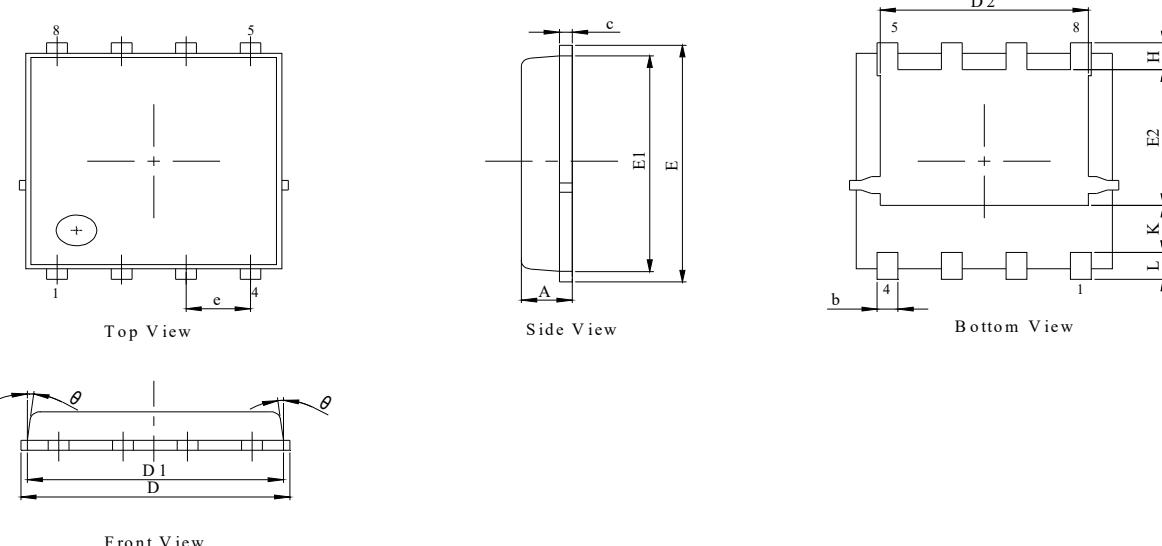


Figure 13: Normalized Maximum Transient Thermal Impedance

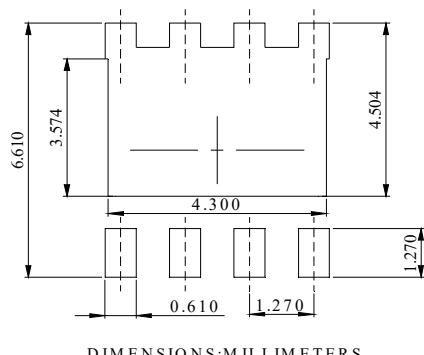
**PDFN5x6-8L Package Information****Package Outline**

Front View

**NOTES:**

1. Dimension and tolerance per ASME Y14.5M, 1994.
2. All dimensions in millimeter (angle in degree).
3. Dimensions D1 and E1 do not include mold flash protrusions or gate burrs.

DIM .	MILLIMETER		
	M IN .	N O M .	M AX .
A	0.90	1.00	1.10
b	0.31	0.41	0.51
c	0.20	0.25	0.30
D	5.00	5.20	5.40
D1	4.95	5.05	5.15
D2	4.00	4.10	4.20
E	6.05	6.15	6.25
E1	5.50	5.60	5.70
E2	3.42	3.53	3.63
e	1.27BSC		
H	0.60	0.70	0.80
L	0.50	0.70	0.80
K	1.23 REF		
θ	-	-	10°

**Recommended Soldering Footprint**

DIMENSIONS:MILLIMETERS